

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/625,208	<b>Applicant(s)/Patent under Reexamination</b> FARMER ET AL.
	<b>Examiner</b> Alex Liew	<b>Art Unit</b> 2624

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
382/224 (limited to text search)	11/6/2006	AL
Overall East Text search	11/6/2006	AL
IEEE Database (limited to text search)	11/17/2006	AL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner